

**Search Notes**

Application/Control No.

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Examiner

Tam Nguyen

Applicant(s)/Patent under  
Reexamination

HUSTED ET AL.

Art Unit

3764

**SEARCHED**

Class	Subclass	Date	Examiner
482	51- 53,57,70, 79,80	2/24/2006	TN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR